MSKSEMI 美森科













ESD

TV

TSS

MOV

GDT

PIFD

NTMFS4C03NT1G-MS

Product specification





Description

The NTMFS4C03NT1G-MS uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

Features

Vps = 30V Ip =150A

 $RDS(ON) < 2.4m\Omega VGS=10V$

Application

Battery protection

Load switch

Uninterruptible power supply

Reference News

PACKAGE OUTLINE	N-Channel MOSFET	Marking
S S S S S S S S S S S S S S S S S S S	G S	MSKSEMI S4C03N N30
DFN5X6-8L		

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
V _G s	Gate- Source Voltage	±20	V
In @Tc=25°C	Continuous Drain Current, V gs @ 10V ¹	150	A
ID @Tc=100°C	Continuous Drain Current, V gs @ 10V ¹	80	А
Ірм	Pulsed Drain Current ²	160	А
EAS	Single Pulse Avalanche Energy ³	180	mJ
las	Avalanche Current	60	Α
P _D @ T _C =250	Total Power Dissipation ⁴	187	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-Ambient ¹	62	°C/ W
Rejc	Thermal Resistance Junction- Case ¹	1.1	°C/ W



Electrical Characteristics (TA=25℃unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =250uA		30			V
△ BVDSS/ △ TJ	BVDSS Temperature Coefficient	Reference to 250 , I _D =1mA		0.014		V/°C
Descour	Static Ducin Course On Besistance?	Vgs=10V , Ip=30A		2	2.4	0
Rds(on)	Static Drain-Source On-Resistance ²	Vgs=4.5V , Ip=15A		2.5	3.2	mΩ
V _{GS(th)}	Gate Threshold Voltage	\\\	1.2		2.5	V
$^{\triangle}V$ GS(th)	V _{GS(th)} Temperature Coefficient	Vgs=Vps , Ip =250uA		-4		Mv/°C
la a a	Drain Sauraa Laakaga Currant	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	uA
loss	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
lgss	Gate-Source Leakage Current V _{GS} = ±20V , V _{DS} =0V				±100	nA
gfs	Forward Transconductance	Vps=5V , Ip=30A		50		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Qg	Total Gate Charge (4.5V)			56.9		
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =10V , I _D =15A		13.8		nC
Qgd	Gate-Drain Charge			23.5		
T _{d(on)}	Turn-On Delay Time			20.1		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V , R _G =3.3 Ω ,		6.3		
Td(off)	Turn-Off Delay Time I _D =1A			124.6		ns
Tf	Fall Time			15.8		
Ciss	Input Capacitance			4345		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		340		pF
Crss	Reverse Transfer Capacitance			225		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			150	Α
VsD	Diode Forward Voltage ²	V _G s=0V , I _S =1A , T _J =250			1.2	V

Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leqq 300us , duty cycle $\,\leqq\,$ 2%
- $3. The \ EAS \ data \ shows \ Max. \ rating \ . \ The \ test \ condition \ is \ V_{DD}=25V, V_{GS}=10V, L=0.1 mH, I_{AS}=60A$
- 5.The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.
- 6. Package limitation current is 85A.



Typical Characteristics

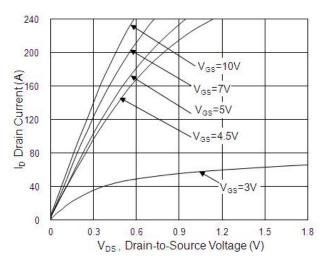
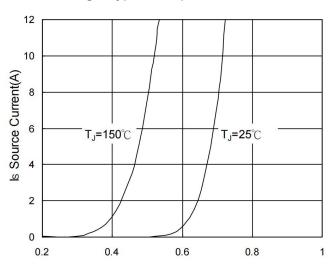


Fig.1 Typical Output Characteristics



 $\label{eq:VSD} V_{SD}\,,\,Source\mbox{-to-Drain Voltage (V)}$ Fig. 3 Forward Characteristics of Reverse

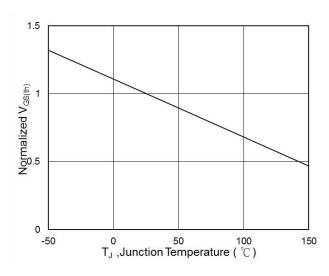


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

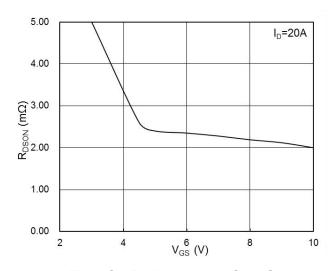
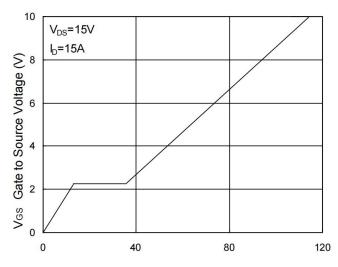


Fig.2 On-Resistance v.s Gate-Source



 $\mathsf{Q}_\mathsf{G}\,,$ Total Gate Charge (nC) Fig. 4 Gate-Charge Characteristics

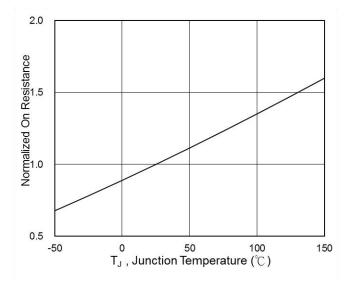
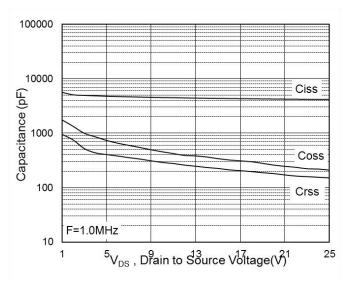


Fig. 6 Normalized RDSON v.s TJ





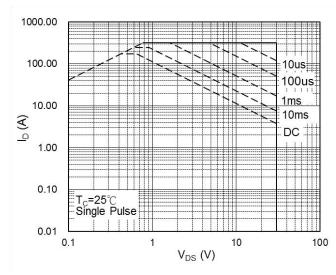


Fig.7Capacitance

Fig.8Safe Operating Area

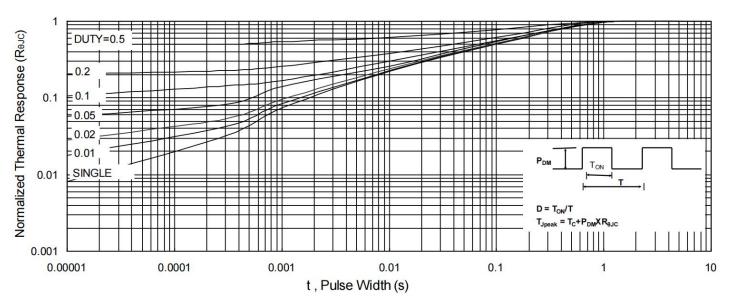


Fig.9 Normalized Maximum Transient Thermal Impedance

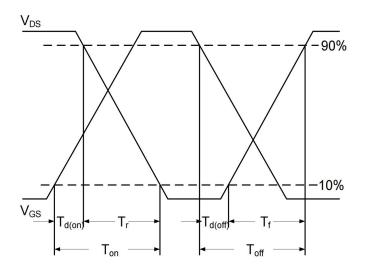
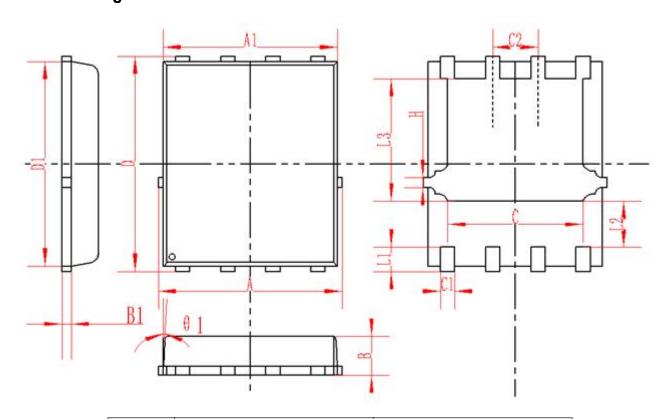


Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Switching Waveform



DFN5X6-8L Package Information



SYMBOL	MM			INCH		
STIVIDOL	MIN	NOM	MAX	MIN NOM N		MAX
А	4.95	5	5.05	0.195	0.197	0.199
A1	4.82	4.9	4.98	0.190	0.193	0.196
D	5.98	6	6.02	0.235	0.236	0.237
D1	5.67	5.75	5.83	0.223	0.226	0.230
В	0.9	0.95	1	0.035	0.037	0.039
B1	0.254REF			0.010REF		
С	3.95	4	4.05	0.156	0.157	0.159
C1	0.35	0.4	0.45	0.014	0.016	0.018
C2	1.27TYP			0.5TYP		
θ1	8。	10 _°	12。	8。	10 _°	12。
L1	0.63	0.64	0.65	0.025	0.025	0.026
L2	1.2	1.3	1.4	0.047	0.051	0.055
L3	3.415	3.42	3.425	0.134	0.135	0.135
Н	0.24	0.25	0.26	0.009	0.010	0.010

REEL SPECIFICATION

P/N	PKG	QTY
NTMFS4C03NT1G-MS	DFN5X6-8L	5000



Attention

- Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.
- MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.
- Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer'sproducts or equipment.
- MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possiblethat these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents—or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuitsfor safedesign, redundant design, and structural design.
- In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, referto the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.